

Features

- 2.15×2.40mm with 1.80mm lens
- High Brightness
- Water Clear
- Small double-end package
- EIA Std. package
- Mono-color type
- Special packaging available upon request
- High reliability

Applications

- PCB mounted infrared sensor
- Infrared emitting for miniature light barrier
- Floppy disk drive
- Optoelectronic switch
- Smoke detector

Description

The INA-912AHIR25.GR is high brightness SMD Axial LED. It is a 1.8mm Lens type LED which can be used in various applications.

Recommended Solder Pattern

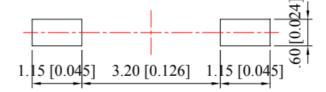
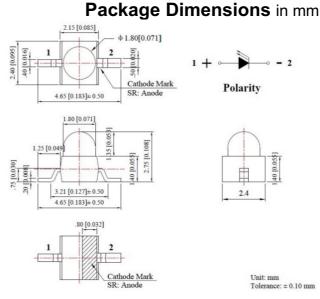


Figure 1. INA-912AHIR25.GR Solder Pattern





Notes:

- 1. All dimensions are in millimeters (inches).
- 2. Tolerance is ± 0.25 mm (.010") unless otherwise noted.



Absolute Maximum Rating at 25°C (Note)

Product	Emission Color	P₀ (mW)	l⊧ (mA)	I _{FP} * (A)	V _R (V)	Top (°C)	Tst (°C)
INA-912AHIR25.GR	Infrared	90	50	1.00	5	-40°C~+80°C	-40°C~+85°C

Notes

1. Derate linearly as shown in derating curve.

2. Duty Factor = 10%, Frequency = 1 kHz

Electrical Characteristics T_A = 25°C (Note)

	Emission Color	l⊧(mA)	V _F (V)				λ(nm)		Viewing Angle Ee (mW/sr		W/sr)	//sr)						
Product			IF=20mA			IF=100mA, tp=100µs, tp/T=0.01		λ _D	λP	Δλ	201/2	IF	=20m/	٩	tp=	100m/ 100µs T=0.0	s,	
INA-912AHIR25.GR	Infrared	20	min	typ	max	min	typ	max	_	940	50	25	min	typ	max	min	typ	max
			0.8	1.2	1.5	-	1.6	1.8		540			3	6	-	-	15	-

Notes

1. Performance guaranteed only under conditions listed in above tables.

2. A luminous intensity is measured with a light sensor and filter combination that approximates the CIE eye-response curve.

3. 201/2 is the o -axis angle where the luminous intensity is 1/2 the peak intensity.

4. The dominant wavelength (λd) is derived from the CIÉ chromaticity diagram and represents the single wavelength which defines the color of the device.

ESD Precaution

ATTENTION: Electrostatic Discharge (ESD) protection

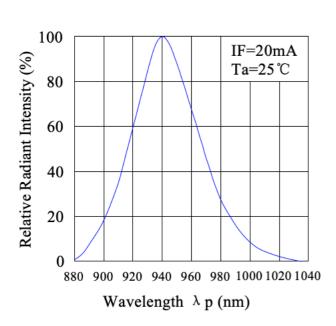


The symbol above denotes that ESD precaution is needed. ESD protection for GaP and AlGaAs based chips is necessary even though they are relatively safe in the presence of low static-electric discharge. Parts built with AlInGaP, GaN, or/and InGaN based chips are STATIC SENSITIVE devices. ESD precaution must be taken during design and assembly. If manual work or processing is needed, please ensure the device is adequately protected from ESD during the process.

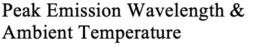
Please be advised that normal static precautions should be taken in the handling and assembly of this device to prevent damage or degradation which may be induced by electrostatic discharge (ESD).

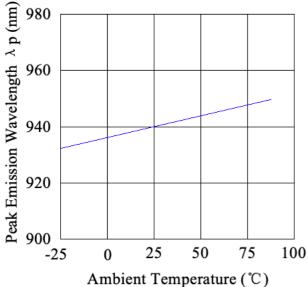


Typical Characteristic Curves Infrared

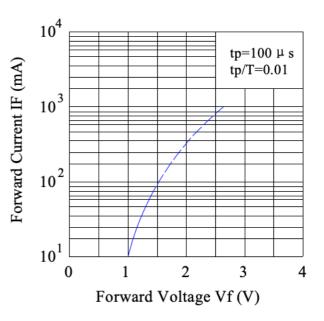


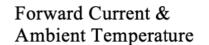
Spectral Distribution

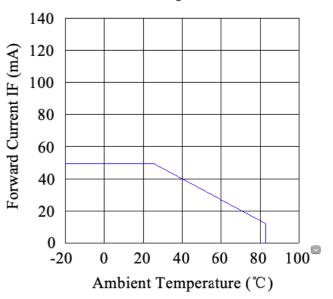




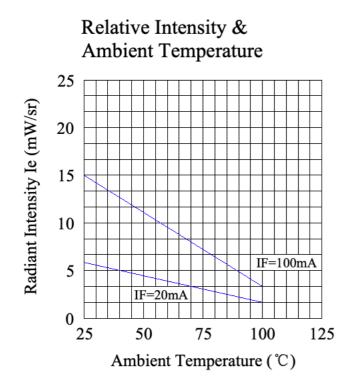
Forward Current & Forward Voltage



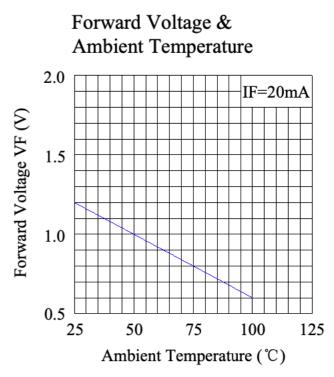




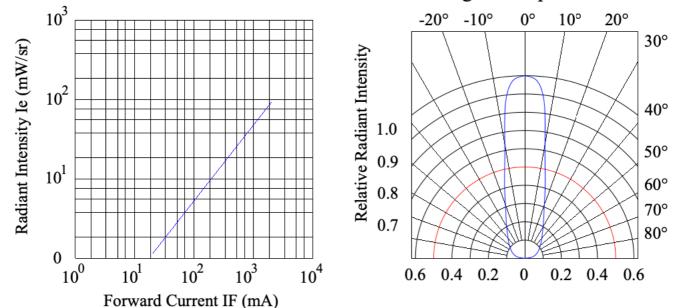




Relative Intensity & Forward Current



Relative Radiant Intensity & Angular Displacement

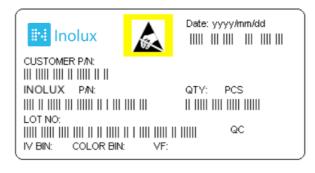




Ordering Information

Product	Emission Color	Test Current I⊧ (mA)	EA (my//er)		Ee (mW/sr) VF (V) Part Nu		
	Infrarad	20	IF=20mA	IF=100mA, tp=100µs, tp/T=0.01	IF=20mA	IF=100mA, tp=100µs, tp/T=0.01	
INA-912AHIR25.GR	Infrared		6	15	1.2	1.6	INA-912AHIR25.GR

Label Specifications





Inolux P/N:

I		Ν	А	-	912	А		HIR	25	.GR	Х	Х	Х	Х			
					Package		Package Lens			Color	Color View Angle			Customized Stamp-off			
	.ea	nolux Id frai Axial			912 Lead Ax	frame	(Blank) = Clear Lens	HIR = 940nm	25 = 25 deg.	GR = Gullwing							

Lot No.:

Z	2	0	1	7	01	24	001
Internal		Voor (2017	, 2018,)	Month	Date	Serial	
Tracker			, 2010,)	wonun	Dale	Senai	



Reliability

Item	· · · · · · · · · · · · · · · · · · ·	Standards	Conditions				
	failures For all reliability	Reference J-STD-020	1) Poking at 95°C for 24bra				
Precondition	monitoring tests according	J-51D-020	1.) Baking at 85°C for 24hrs 2.) Moisture storage at 85°C/ 60% R.H. for				
Frecondition	to JEDEC Level 2		168hrs				
	1Q/ 1/ 22/ 0	JESD22-B102-B	Accelerated aging 155°C/ 24hrs				
Solderability	10/1/22/0	And CNS-5068	Tinning speed: 2.5+0.5cm/s				
Soluerability			Tinning: A: 215°C/ 3+1s or B: 260°C/ 10+1s				
		CNS-5067	Dipping soldering terminal only				
Resistance to		0110-0007	Soldering bath temperature				
soldering heat			A: 260+/-5°C; 10+/-1s				
solucing field			B: 350+/-10°C; 3+/-0.5s				
	1Q/ 1/ 40/ 0	CNS-11829	1.) Precondition: 85°C baking for 24hrs				
Operating life test		0110-11023	85°C/ 60%R.H. for 168hrs				
operating me test			2.) Tamb25°C; IF=20mA; duration 1000hrs				
High humidity,	1Q/ 1/ 45/ 0	JESD-A101-B	Tamb: 85°C				
high temperature			Humidity: 85% R.H., IF=5mA				
bias			Duration: 1000hrs				
	1Q/ 1/ 20	IN specs.	Tamb: 55°C				
High temperature			IF=20mA				
bias			Duration: 1000hrs				
	1Q/ 1/ 40/ 0		Tamb25°C, If=20mA,, Ip=100mA, Duty				
Pulse life test			cycle=0.125 (tp=125µs,T=1sec)				
			Duration 500hrs)				
	1Q/ 1/ 76/ 0	JESD-A104-A	A cycle: -40 degree C 15min; +85 degree C				
Tamananatura		IEC 68-2-14, Nb	15min				
Temperature			Thermal steady within 5 min				
cycle			300 cycles				
			2 chamber/ Air-to-air type				
High humidity	1Q/ 1/ 40/ 0	CNS-6117	60+3°C				
storage test			90+5/-10% R.H. for 500hrs				
High temperature	1Q/ 1/ 40/ 0	CNS-554	100+10°C for 500hrs				
storage test							
Low temperature	1Q/ 1/ 40/ 0	CNS-6118	-40+5°C for 500hrs				
storage test							



Revision History

Changes since last revision	Page	Version No.	Revision Date
Initial Release		1.0	01-27-2021
Image Revision		1.1	04-14-2022

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